

MOS INTEGRATED CIRCUIT μ PD78F4225

16/8-BIT SINGLE-CHIP MICROCONTROLLERS

DESCRIPTION

The μ PD78F4225 is a product in the μ PD784225 subseries in the 78K/IV series.

The μ PD78F4225 has a flash memory in the place of the internal ROM of the μ PD784225. Data can be written to or erased from the flash memory of the μ PD78F4225 with the microcontroller mounted on a printed wiring board.

The functions are explained in detail in the following user's manuals. Be sure to read this manual when designing your system.

μPD784225, 784225Y Subseries User's Manual - Hardware : Planned 78K/IV Series User's Manual - Instruction : U10905E

FEATURES

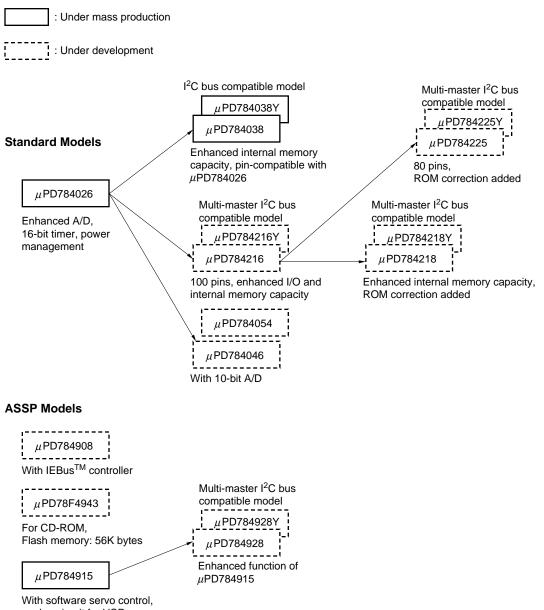
- Pin-compatible with mask ROM model (except VPP pin)
- Flash memory: 128K bytes
- Internal RAM : 4352 bytes
- Same operating voltage as mask ROM model: VDD = 1.8 to 5.5 V

ORDERING INFORMATION

Part Number	Package
μPD78F4225GC-8BT	80-pin plastic QFP (14 $ imes$ 14 mm)
μPD78F4225GK-BE9	80-pin plastic TQFP (fine pitch) (12 $ imes$ 12 mm)

The information contained in this document is being issued in advance of the production cycle for the device. The parameters for the device may change before final production or NEC Corporation, at its own discretion, may withdraw the device prior to its production.

78K/IV SERIES PRODUCT DEVELOPMENT



analog circuit for VCRs, enhanced timer

FUNCTIONS

Item			Function					
Number of basic	instructions	113						
(mnemonics)		8 bits \times 16 registers \times 8 banks, or 16 bits \times 8 registers \times 8 banks (memory mapping)						
General-purpose register		-						
Minimum instruc	tion execution		ns/1280 ns/2560 ns (main system lock: fxt = 32.768 KHz)	n clock: $fxx = 12.5 \text{ MHz}$)				
Internal	Flash memory	128 KB						
memory	RAM	4352 bytes						
Memory space		1 MB with program an	d data spaces combined					
I/O port	Total	67						
	CMOS Input	8						
	CMOS I/O	59						
Pins with ancillary	Pins with pull-up resistor	57						
functions ^{Note}	LEDs direct drive output	16						
Real-time output	t port	4 bits \times 2, or 8 bits \times 1						
Timer/counter		16-bit timer/counter :	timer register \times 1 Capture/compare register \times 2	Pulse output • PWM/PPG output • Square wave output • One-shot pulse output				
		8-bit timer/counter 1 :	timer register \times 1	Pulse output				
			Compare register \times 1	 PWM output 				
		Square wave output						
		8-bit timer/counter 2 :	•	Pulse output				
		Compare register × 1 • PWM output • Square wave output						
		8-bit timer/counter 5 :	timer register × 1					
			Compare register × 1					
		8-bit timer/counter 6 : timer register × 1 Compare register × 1						
Serial interface		UART/IOE (3-wire serial I/O): 2 channels (on-chip baud rate generator) CSI (3-wire serial I/O): 1 channel						
A/D converter		8-bit resolution × 8 ch	annels					
D/A converter		8-bit resolution × 2 channels						
Clock output		Selectable from fxx, fxx/2, fxx/2 ² , fxx/2 ³ , fxx/2 ⁴ , fxx/2 ⁵ , fxx/2 ⁶ , fxx/2 ⁷ , fxt						
Buzzer output		Selectable from fxx/2 ¹⁰ , fxx/2 ¹¹ , fxx/2 ¹² , fxx/2 ¹³						
Watch timer		1 channel						
Watchdog timer		1 channel						
Standby		HALT/STOP/IDLE mode In power-saving mode (with subsystem clock): HALT/IDLE mode						
Interrupt	Hardware	25 (internal: 18, exter	25 (internal: 18, external: 7)					
	Software	BRK instruction, BRKC	CS instruction, operand error					
	Non-maskable	Internal: 1, external:	1					
	Maskable	Internal: 17, external:	6					
		 4 programmable priority levels 3 service modes: vectored interrupt/macro service/context switching 						
Supply voltage		VDD = 1.8 to 5.5 V						
Package		• 80-pin plastic QFP (14 \times 14 mm)						
		80-pin plastic TQFP	(fine pitch) (12 \times 12 $$ mm)					

 $\ensuremath{\textbf{Note}}$ The pins with ancillary functions are included in the I/O pins.

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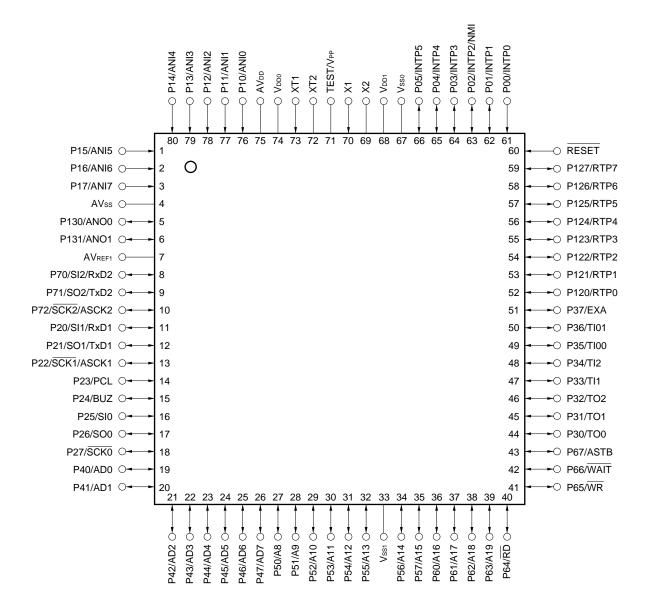
1. DIFFERENCES AMONG MODELS IN $\mu \text{PD784225}$ SUBSERIES

The only difference among the μ PD784224 and 784225 lies in the internal memory capacity. The μ PD78F4225 is provided with a 128-KB flash memory instead of the mask ROM of the above models. These differences are summarized in Table 1-1.

Part Number Item	μPD784224	μPD784225	μPD78F4225
Internal ROM	96 KBytes (mask ROM)	128 KBytes (mask ROM)	128 KBytes (flash memory)
Internal RAM	3584 Bytes	4352 Bytes	
Internal memory size switching register (IMS)	None		Provided
VPP pin	None		Provided

Table 1-1. Differences among Models in μ PD784225 Subseries

- 2. PIN CONFIGURATION (Top View)
 - 80-pin plastic QFP (14 \times 14 mm) μ PD78F4225GC-8BT
 - 80-pin plastic TQFP (fine pitch) (12 \times 12 mm) μ PD78F4225GK-BE9

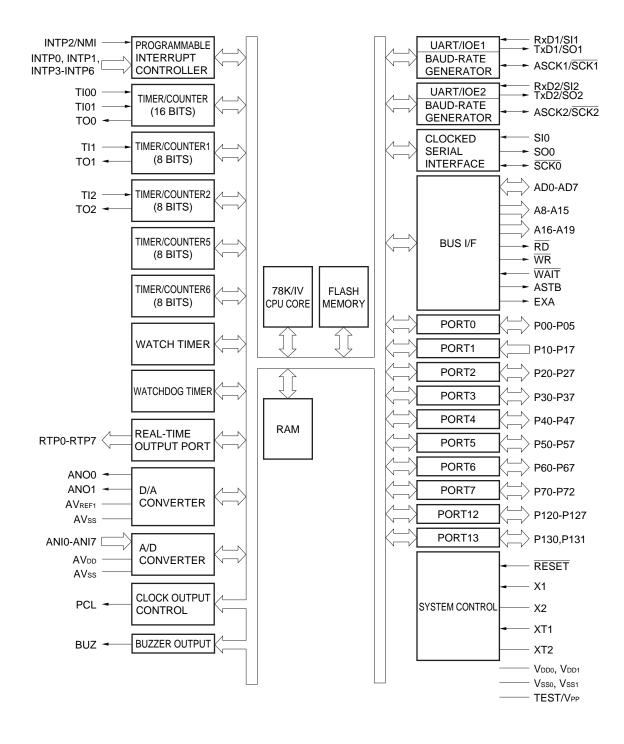


Notes 1. Directly connect the TEST/VPP pin to Vsso in normal operation mode.

- 2. Connect the AVss pin to Vsso.
- **Remark** When using in applications where noise from inside the microcomputer has to be reduced, it is recommended to take countermeasures against noise such as supplying power to VDD0 and VDD1 independently, and connecting Vss0 and Vss1 to different ground lines.

A8-A19		Address Bus	P120-P127		Port12
AD0-AD7	-	Address/Data Bus	P130, P131	:	Port13
-				•	
ANIO-ANI7	:	Analog Input	PCL	:	Programmable Clock
ANO0, ANO1	:	Analog Output	RD	:	Read Strobe
ASCK1, ASCK2	:	Asynchronous Serial Clock	RESET	:	Reset
ASTB	:	Address Strobe	RTP0-RTP7	:	Real-time Output Port
AVdd	:	Analog Power Supply	RxD1, RxD2	:	Receive Data
AVREF1	:	Analog Reference Voltage	SCK0-SCK2	:	Serial Clock
AVss	:	Analog Ground	SI0-SI2	:	Serial Input
BUZ	:	Buzzer Clock	SO0-SO2	:	Serial Output
EXA	:	External Access Status Output	TEST	:	Test
INTP0-INTP5	:	Interrupt from Peripherals	TI00, TI01, TI1-TI2	:	Timer Input
NMI	:	Non-maskable Interrupt	TO0-TO2	:	Timer Output
P00-P05	:	Port0	TxD1, TxD2	:	Transmit Data
P10-P17	:	Port1	Vddo, Vdd1	:	Power Supply
P20-P27	:	Port2	Vpp	:	Programming Power Supply
P30-P37	:	Port3	Vsso, Vss1	:	Ground
P40-P47	:	Port4	WAIT	:	Wait
P50-P57	:	Port5	WR	:	Write Strobe
P60-P67	:	Port6	X1, X2	:	Crystal (Main System Clock)
P70-P72	:	Port7	XT1, XT2	:	Crystal (Subsystem Clock)

3. BLOCK DIAGRAM



4. PIN FUNCTION

4.1 Port Pins (1/2)

Pin Name	I/O	Alternate Function	Function
P00	I/O	INTP0	Port 0 (P0):
P01		INTP1	• 6-bit I/O port
P02		INTP2/NMI	 Can be set in input or output mode bit-wise. Pins set in input mode can be connected to internal pull-up
P03		INTP3	resistors in software bit-wise.
P04		INTP4	-
P05		INTP5	
P10-P17	Input	ANIO-ANI7	Port 1 (P1): • 8-bit input port
P20	I/O	RxD1/SI1	Port 2 (P2):
P21		TxD1/SO1	8-bit I/O port
P22		ASCK1/SCK1	 Can be set in input or output mode bit-wise. Pins set in input mode can be connected to internal pull-up
P23		PCL	resistors in software bit-wise.
P24		BUZ	
P25		SI0	
P26		SO0	-
P27		SCKO	-
P30	I/O	ТОО	Port 3 (P3):
P31		TO1	8-bit I/O port
P32		TO2	 Can be set in input or output mode bit-wise. Pins set in input mode can be connected to internal pull-up
P33		TI1	resistors in software bit-wise.
P34		TI2	
P35		T100	-
P36		TI01	-
P37		EXA	
P40-P47	I/O	AD0-AD7	 Port 4 (P4): 8-bit I/O port Can be set in input or output mode bit-wise. All pins set in input mode can be connected to internal pull-up resistors in software. Can drive LEDs.
P50-P57	I/O	A8-A15	 Port 5 (P5): 8-bit I/O port Can be set in input or output mode bit-wise. All pins set in input mode can be connected to internal pull-up resistors in software. Can drive LEDs.

4.1 Port Pins (2/2)

Pin Name	I/O	Alternate Function	Function
P60	I/O	A16	Port 6 (P6):
P61		A17	8-bit I/O port Con he get in input or output mode hit wise
P62		A18	 Can be set in input or output mode bit-wise. All pins set in input mode can be connected to internal pull-up
P64		RD	resistors in software.
P65		WR	
P66		WAIT	
P67		ASTB	
P70	I/O	RxD2/SI2	Port 7 (P7): • 3-bit I/O port
P71		TxD2/SO2	 Can be set in input or output mode bit-wise. Pins set in input mode can be connected to internal pull-up resistor
P72	-	ASCK2/SCK2	 in software bit-wise.
P120-P127	I/O	RTP0-RTP7	 Port 12 (P12): 8-bit I/O port Can be set in input or output mode bit-wise. Pins set in input mode can be connected to internal pull-up resistor in software bit-wise.
P130, P131	I/O	ANO0, ANO1	Port 13 (P13): • 2-bit I/O port • Can be set in input or output mode bit-wise.

4.2 Pins Other Than Port Pins (1/2)

Pin Name	I/O	Alternate Function	Function			
TI00	Input	P35	External count clock input to 16-bit timer register			
TI01		P36	Capture trigger signal input to capture/compare register 00			
TI1		P33	External count clock input to 8-bit timer register 1			
TI2		P34	External count clock input to 8-bit timer register 2			
ТОО	Output	P30	16-bit timer output (shared by 14-bit PWM output)			
TO1		P31	8-bit timer output (shared by 8-bit PWM output)			
TO2		P32				
RxD1	Input	P20/SI1	Serial data input (UART1)			
RxD2		P70/SI2	Serial data input (UART2)			
TxD1	Output	P21/SO1	Serial data output (UART1)			
TxD2		P71/SO2	Serial data output (UART2)			
ASCK1	Intput	P22/SCK1	Baud rate clock input (UART1)			
ASCK2	1	P72/SCK2	Baud rate clock input (UART2)			
SI0	Input	P25	Serial data input (3-wire serial clock I/O0)			
SI1		P20/RxD1	Serial data input (3-wire serial clock I/O1)			
SI2		P70/RxD2	Serial data input (3-wire serial clock I/O2)			
SO0	Output	P26	Serial data output (3-wire serial I/O0)			
SO1		P21/TxD1	Serial data output (3-wire serial I/O1)			
SO2		P71/TxD2	Serial data output (3-wire serial I/O2)			
SCK0	I/O	P27	Serial clock input/output (3-wire serial I/O0)			
SCK1		P22/ASCK1	Serial clock input/output (3-wire serial I/O1)			
SCK2	-	P72/ASCK2	Serial clock input/output (3-wire serial I/O2)			
NMI	Input	P02/INTP2	Non-maskable interrupt request input			
INTP0		P00	External interrupt request input			
INTP1		P01	1			
INTP2		P02/NMI				
INTP3	-	P03				
INTP4		P04				
INTP5		P05				
PCL	Output	P23	Clock output (for trimming main system clock and subsystem clock)			
BUZ	Output	P24	Buzzer output			
RTP0-RTP7	Output	P120-P127	Real-time output port that outputs data in synchronization with trigger			
AD0-AD7	I/O	P40-P47	Low-order address/data bus when external memory is connected			
A8-A15	Output	P50-P57	Middle-order address bus when external memory is connected			
A16-A19	1	P60-P63	High-order address bus when external memory is connected			
RD	Output	P64	Strobe signal output for read operation of external memory			
WR	1	P65	Strobe signal output for write operation of external memory			
WAIT	Input	P66	To insert wait state(s) when external memory is accessed			

4.2 Pins Other Than Port Pins (2/2)

Pin Name	I/O	Alternate Function	Function	
ASTB	Output	P67	Strobe output to externally latch address information output to ports 4 through 6 to access external memory	
EXA	Output	P37	External access status output	
RESET	Input	_	System reset input	
X1	Input	_	To connect main system clock oscillation crystal	
X2	_			
XT1	Input	_	To connect subsystem clock oscillation crystal	
XT2	—			
ANI0-ANI7	Input	P10-P17	Analog voltage input for A/D converter	
ANO0, ANO1	Output	P130, P131	Analog voltage output for D/A converter	
AV _{REF1}	_		To apply reference voltage for D/A converter	
AVdd			Positive power supply for A/D converter. Connected to VDD0.	
AVss			GND for A/D converter and D/A converter. Connected to Vsso.	
V _{DD0}			Positive power supply for port block	
Vsso			GND potential for port block	
VDD1			Positive power supply (except port block)	
Vss1			GND potential (except port block)	
TEST		Vpp	Directly connect this pin to Vss (this pin is for IC test).	
Vpp		TEST	Sets flash memory programming mode. To apply a high voltage when program is written or verified.	

4.3 I/O Circuit Type of Respective Pins and Recommended Connections of Unused Pins

Table 4-1 shows symbols indicating the I/O circuit types of the respective pins and the recommended connection of unused pins.

For the circuit diagram of each type of I/O circuit, refer to Figure 4-1.

Table 4-1. I/O Circuit Type of Respective Pins and Recommended Connections of Unused Pins (1/2)

Pin Name	I/O Circuit Type	I/O	Recommended Connections of Unused Pins
P00/INTP0	8-C	I/O	Input : Individually connected to Vsso via resistor
P01/INTP1			Output: Open
P02/INTP2/NMI			
P03/INTP3-P05/INTP5			
P10/ANI0-P17/ANI7	9	Input	Connected to Vsso or VDDo
P20/RxD1/SI1	10-B	I/O	Input : Individually connected to Vsso via resistor
P21/TxD1/SO1			Output: Open
P22/ASCK1/SCK1			
P23/PCL			
P24/BUZ			
P25/SI0			
P26/SO0			
P27/SCK0			
P30/TO0-P32/TO2	8-C		
P33/TI1, P34/TI2			
P35/TI00, P36/TI01			
P37/EXA			
P40/AD0-P47/AD7	5-H		
P50/A8-P57/A15			
P60/A16-P63/A19			
P64/RD			
P65/WR			
P66/WAIT			
P67/ASTB			
P70/RxD2/SI2	8-C		
P71/TxD2/SO2			
P72/ASCK2/SCK2			
P120/RTP0-P127/RTP7			
P130/ANO0, P131/ANO1	12-C		

Table 4-1. I/O Circuit Type of Respective Pins and Recommended Connections of Unused Pins (2/2)

Pin Name	I/O Circuit Type	I/O	Recommended Connections of Unused Pins
RESET	2	Input	—
XT1	16		Connected to Vsso
XT2		_	Open
AV _{REF1}	_		Connected to VDD0
AVDD			
AVss			Connected to Vsso
TEST/Vpp			Directly connected to Vsso

Remark Because the circuit type numbers are standardized among the 78K series products, they are not sequential in some models (i.e., some circuits are not provided).

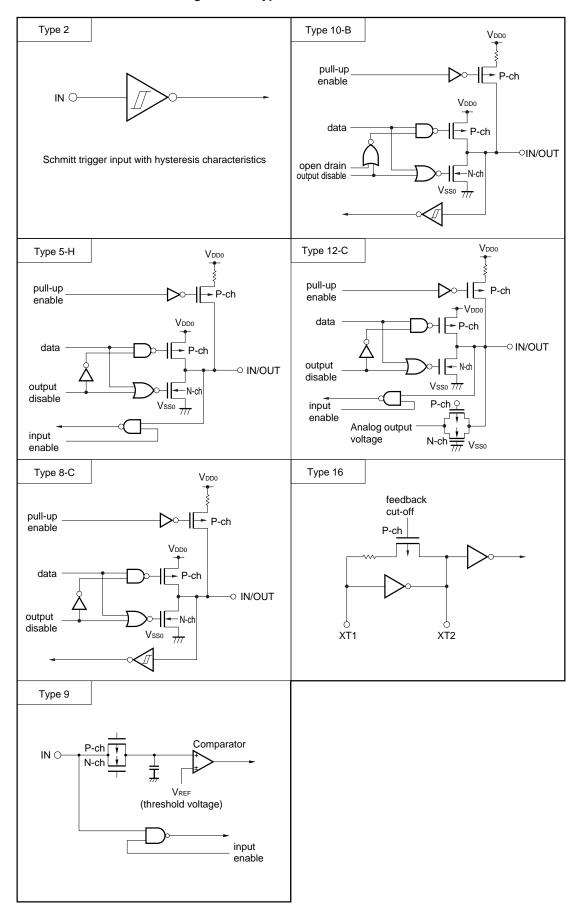


Figure 4-1. Types of Pin I/O Circuits

5. INTERNAL MEMORY SIZE SELECT REGISTER (IMS)

The IMS is a register that prevents in software a part of the internal memory from being used. By using this register, the memory of the μ PD78F4225 can be mapped in the same manner as a mask ROM model with different internal memory (ROM and RAM) capacity.

This register is set by using an 8-bit memory manipulation instruction.

Its value is set to FFH by RESET input.



Addres	Address: 0FFFCH At reset: FFH		W					
	7	6	5	4	3	2	1	0
IMS	1	1	ROM1	ROM0	1	1	RAM1	RAM0

ROM1	ROM0	Selects internal ROM capacity
0	0	48K bytes
0	1	64K bytes
1	0	96K bytes
1	1	128K bytes

RAM1	RAM0	Selects peripheral RAM capacity	
0	0	1536 bytes	
0	1	2304 bytes	
1	0	3072 bytes	
1	1	3840 bytes	

Caution IMS is not provided on the mask ROM models (µPD784224 and 784225).

The value to be set to the IMS to map the memory of the μ PD78F4225 in the same manner as the mask ROM model is shown in Table 5-1.

Table 5-1. Set Value of Internal Memory Size Select Register (IMS)

Mask ROM Model	Set Value of IMS	
μPD784225	EEH	
μPD784226	FFH	

6. PROGRAMMING FLASH MEMORY

The flash memory can be written with the μ PD78F4225 mounted on the target board (on-board). To do so, connect a dedicated flash writer (Flashpro II) to the host machine and target system.

Remark Flashpro II is a product of Naito Densei Machida Mfg. Co., Ltd.

6.1 Selecting Communication Mode

To write the flash memory, use Flashpro II and serial communication. Select a serial communication mode from those listed in Table 6-1 in the format shown in Figure 6-1. Each communication mode is selected by the number of VPP pulses shown in Table 6-1.

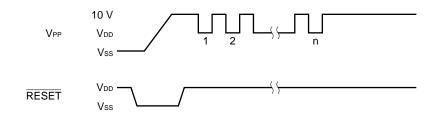
Communication Mode	Number of Channels	Pins Used	Number of VPP Pulses
3-wire serial I/O	3	SCK0/P27 SO0/P26 SI0/P25	0
		SCK1/ASCK1/P22 SO1/TxD1/P21 SI1/RxD1/P20	1
		SCK2/ASCK2/P72 SO2/TxD2/P71 SI2/RxD2/P70	2
UART	2	TxD1/SO1/P21 RxD1/SI1/P20	8
		TxD2/SO2/P71 RxD2/SI2/P70	9
Psendo-3-wire serial I/O ^{Note}	1	P32/TO2 (serial clock I/O) P31/TO1 (serial data output) P30/TO0 (serial data output)	12

Table 6-1. Communication Modes

Note Performs serial transfer by controlling port by software.

Caution Be sure to select a communication mode with the number of VPP pulses shown in Table 6-1.

Figure 6-1. Communication Mode Selecting Format



6.2 Flash Memory Programming Function

The flash memory is written by transferring or receiving commands and data in a selected communication mode. The major functions of flush memory programming are listed in Table 6-2.

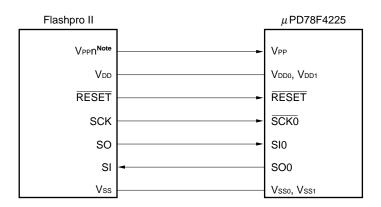
Function	Description	
Batch erasure	Erases all contents of memory.	
Block erasure	Erases contents of specified memory block.	
Batch blank check	Checks erased status of entire memory.	
Block blank check	Checks erased status of specified block	
Data write	Writes flash memory based on write start address and number of data to be written (in bytes).	
Batch verify	Compares all contents of memory with input data.	
Block verify	Compares contents of specified memory block with input data.	

Table 6-2. Major Functions of Flash Memory Programming

6.3 Connecting Flashpro II

The Flashpro II and μ PD78F4225 are connected differently depending on the selected communication mode. Figures 6-2 through 6-5 show the connections in the respective communication modes.

Figure 6-2. Connection of Flashpro II in 3-Wire Serial I/O Mode (When Using 3-Wire Serial I/O 0)



Note n = 1, 2

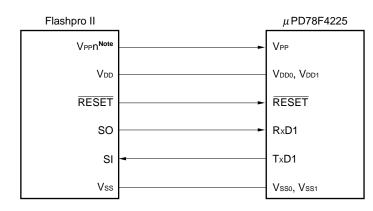
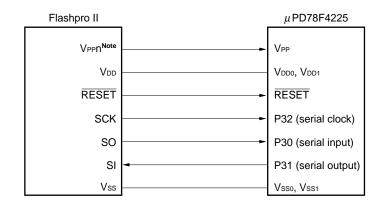


Figure 6-3. Connection of Flashpro II in UART Mode (When Using UART1)



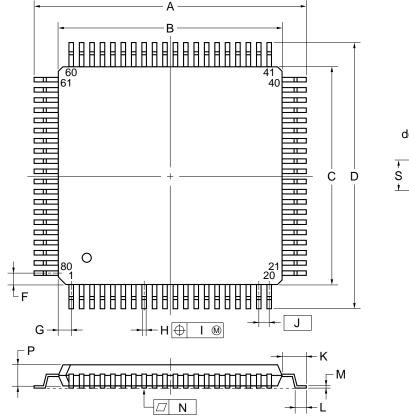




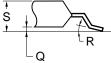
Note n = 1, 2

7. PACKAGE DRAWINGS

80 PIN PLASTIC QFP (14×14)



detail of lead end

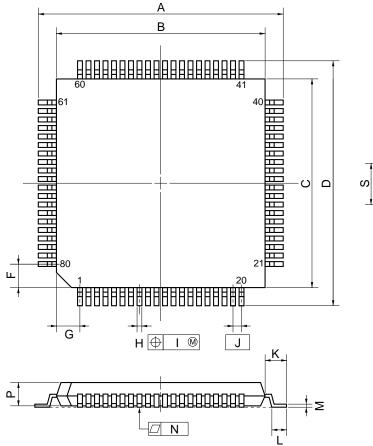


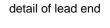
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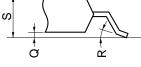
Each lead centerline is located within 0.13 mm (0.005 inch) of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS	INCHES
Α	17.20±0.20	0.677±0.008
В	14.00±0.20	0.551 +0.009 -0.008
С	14.00±0.20	$0.551^{+0.009}_{-0.008}$
D	17.20±0.20	0.677±0.008
F	0.825	0.032
G	0.825	0.032
Н	0.32±0.06	$0.013^{+0.002}_{-0.003}$
I	0.13	0.005
J	0.65 (T.P.)	0.026 (T.P.)
ĸ	1.60±0.20	0.063±0.008
L	0.80±0.20	$0.031^{+0.009}_{-0.008}$
М	$0.17 \substack{+0.03 \\ -0.07}$	0.007+0.001 -0.003
N	0.10	0.004
Р	1.40±0.10	0.055±0.004
Q	0.125±0.075	0.005±0.003
R	3°+7° -3°	3°+7° -3°
S	1.70 MAX.	0.067 MAX.
		P80GC-65-8BT

80 PIN PLASTIC TQFP (FINE PITCH) (12)







ITEM	MILLIMETERS	INCHES
	WILLIWEIERS	
А	14.0±0.2	$0.551^{+0.009}_{-0.008}$
В	12.0±0.2	$0.472^{+0.009}_{-0.008}$
С	12.0±0.2	$0.472^{+0.009}_{-0.008}$
D	14.0±0.2	$0.551^{+0.009}_{-0.008}$
F	1.25	0.049
G	1.25	0.049
н	$0.22^{+0.05}_{-0.04}$	0.009±0.002
I	0.10	0.004
J	0.5 (T.P.)	0.020 (T.P.)
к	1.0±0.2	$0.039^{+0.009}_{-0.008}$
L	0.5±0.2	$0.020^{+0.008}_{-0.009}$
М	$0.145^{+0.055}_{-0.045}$	0.006±0.002
N	0.10	0.004
Р	1.05	0.041
Q	0.05±0.05	0.002±0.002
R	5°±5°	5°±5°
S	1.27 MAX.	0.050 MAX.
		P80GK-50-BE9-4

NOTE

Each lead centerline is located within 0.10 mm (0.004 inch) of its true position (T.P.) at maximum material condition.

APPENDIX A. DEVELOPMENT TOOLS

The following development tools are available for supporting development of a system using the μ PD78F4225.

Language processor software

RA78K4 ^{Note 1}	Assembler package common to 78K/IV series	
CC78K4 ^{Note 1}	C compiler package common to 78K/IV series	
CC78K4-L ^{Note 1}	C compiler library source file common to 78K/IV series	

Flash memory writing tool

Flashpro II	Dedicated flash writer. Flashpro is the product of Naito Densei Machida Mfg. Co., Ltd.
Product name pending	Adapter for flash memory writing.

Debugging tool

IE-784000-R	In-circuit emulator common to 78K/IV series	
IE-784000-R-BK	Break board common to 78K/IV series	
IE-784218-R-EM1 IE-784000-R-EM	Emulation board for evaluation of μ PD784225 subseries	
IE-70000-98-IF-B	Interface adapter when PC-9800 series (except notebook type) is used as host machine	
IE-70000-98N-IF	Interface adapter and cable when notebook type PC-9800 series is used as host machine	
IE-70000-PC-IF-B	Interface adapter when IBM PC/AT™ is used as host machine	
IE-78000-R-SV3	Interface adapter and cable when EWS is used as host machine	
Product name pending	Emulation probe common to μ PD784225 subseries	
SM78K4 ^{Note 2}	System simulator common to 78K/IV series	
ID78K4 ^{Note 2}	Integrated debugger for IE-784000-R	
DF784225 (Pending)Note 3	Device file for μ PD784225 subseries	

Real-time OS

RX78K/IV ^{Note 3}	Real-time OS for 78K/IV series
MX78K4 ^{Note 4}	OS for 78K/IV series

Remark RA78K4, CC78K4, SM78K4, and ID78K4 are used in combination with DF784225.

- Notes 1. PC-9800 series (MS-DOS™) based
 - IBM PC/AT and compatible machine (PC DOS[™], Windows[™], MS-DOS, IBM DOS[™]) based
 - HP9000 series 700[™] (HP-UX[™]) based
 - SPARCstation[™] (SunOS[™]) based
 - NEWS[™] (NEWS-OS[™]) based
 - 2. PC-9800 series (MS-DOS+Windows) based
 - IBM PC/AT and compatible machine (PC DOS, Windows, MS-DOS, IBM DOS) based
 - HP9000 series 700 (HP-UX) based
 - SPARCstation (SunOS) based
 - 3. PC-9800 series (MS-DOS) based
 - IBM PC/AT and compatible machine (PC DOS, Windows, MS-DOS, IBM DOS) based
 - HP9000 series 700 (HP-UX) based
 - SPARCstation (SunOS) based
 - 4. PC-9800 series (MS-DOS) based
 - IMB PC/AT and compatible machine (PC DOS, Windows, MS-DOS, IBM DOS) based

APPENDIX B. RELATED DOCUMENTS

Documents Related to Device

Document Name	Document No.	
	Japanese	English
µPD784224, 784225 Preliminary Product Information	U12498J	Planned
µPD78F4225 Preliminary Product Information	U12499J	This document
μPD784225, 784225Y Subseries User's Manual - Hardware	Planned	Planned
μ PD784225 Subseries Special Function Register Table	Planned	-
78K/IV Series User's Manual - Instruction	U10905J	U10905E
78K/IV Series Instruction Table	U10594J	-
78K/IV Series Instruction Set	U10595J	-
78K/IV Series Application Note - Software Basics	U10095J	_

Documents Related to Development Tools (User's Manuals)

Document Name		Document No.	
		Japanese	English
RA78K4 Assembler Package	Operation	U11334J	U11334E
	Language	U11162J	-
RA78K Series Structured Assembler Preprocessor		EEU-817	EEU-1402
CC78K4 Series	Operation	EEU-960	_
	Language	EEU-961	_
CC78K Series Library Source File		U12322J	_
IE-784000-R		EEU-5004	EEU-1534
IE-784218-R-EM1		U12155J	U12155E
SM78K4 System Simulator - Windows Based	Reference	U10093J	U10093E
SM78K Series System Simulator	External component user open interface specification	U10092J	U10092E
ID78K4 Integrated Debugger - Windows Based	Reference	U10440J	U10440E
ID78K4 Integrated Debugger - HP9000 Series (HP-UX Based)	Reference	U11960J	Planned

Caution The contents of the above related documents are subject to change without notice. Be sure to use the latest edition of a document for designing.

Documents Related to Embedded Software (User's Manual)

Document Name		Document No.	
		Japanese	English
78K/IV Series Real-Time OS	Fundamental	U10603J	U10603E
	Installation	U10604J	U10604E
	Debugger	U10364J	-
78K/IV Series OS MX78K4	Fundamental	U11779J	_

Other Documents

Document Name	Document No.	
	Japanese	English
IC Package Manual	C10943X	
Semiconductor Device Mounting Technology Manual	C10535J	C10535E
Quality Grades on NEC Semiconductor Devices	C11531J	C11531E
NEC Semiconductor Device Reliability/Quality Control System	C10983J	C10983E
Electrostatic Discharge (ESD) Test	MEM-539	_
Guide to Quality Assurance for Semiconductor Devices	C11893J	MEI-1202
Guide to Microcomputer-Related Products by Third Parties	U11416J	_

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NOTES FOR CMOS DEVICES -

1 PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note: Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

(2) HANDLING OF UNUSED INPUT PINS FOR CMOS

Note: No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS device behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

③ STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note: Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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- Ordering information
- Product release schedule
- · Availability of related technical literature
- Development environment specifications (for example, specifications for third-party tools and components, host computers, power plugs, AC supply voltages, and so forth)
- Network requirements

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